

Notice of References Cited

Application/Control No.

10/602,436

Applicant(s)/Patent Under
Reexamination
LEE ET AL.

Examiner

Thomas J. Magee

Art Unit

2811

Pag 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| | A | US-6,475,869 B1 | 11-2002 | Yu, Bin | 438/303 |
| | B | US-6,633,066 B1 | 10-2003 | Bae et al. | 257/347 |
| | C | US-6,432,754 B1 | 08-2002 | Assaderaghi et al. | 438/149 |
| | D | US-6,737,670 B2 | 05-2004 | Cheng et al. | 257/19 |
| | E | US-6,689,650 B2 | 02-2004 | Gambino et al. | 438/157 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | Literature Digest, "The Highlights of the IEDM 2002," vol. 6, (March, 2003), pp. 1-6. |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.